

<b>Notice of References Cited</b>	Application/Control No. 10/676,454	Applicant(s)/Patent Under Reexamination THIELE, JOHN L.	
	Examiner Nasser Ahmad	Art Unit 1772	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0088928 A1	05-2003	Shizuno et al.	15/104.002
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